

<b>Notice of References Cited</b>	Application/Control No. 10/520,787	Applicant(s)/Patent Under Reexamination MIYOSHI ET AL.	
	Examiner LITON MIAH	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0058493 A1	05-2002	Ikeda et al.	455/403
*	B	US-2002/0191573 A1	12-2002	Whitehill et al.	370/338
*	C	US-6,662,330 B1	12-2003	Hershey, Stephen	714/748
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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**NON-PATENT DOCUMENTS**

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